Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/817,249	NAKANO ET AL.	
Examiner	Art Unit	
Ryan D. Walsh	2852	

SEARCHED				
Class	Subclass	Date	Examiner	
399	350	9/17/2006	RDW	
			*	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	<u> </u>		
	:		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See EAST search history attached	9/13/2006	RDW		
		_		
	,			
		_		